


Search Notes 	Application/Control No. 10675706	Applicant(s)/Patent Under Reexamination SHIN, YOUNG-MIN
	Examiner Flores, Leon	Art Unit 2635

SEARCHED			
Class	Subclass	Date	Examiner
375	354, 356, 357, 359, 373	12/14/2006	LF
370	517	12/14/2006	LF
327	141, 142, 144, 161	12/14/2006	LF

SEARCH NOTES			
Search Notes	Date	Examiner	
Consulted with SPE Vu Le in regards to the patentability of the claims.	12/27/2006	LF	
Checked for double patenting.	12/15/2006	LF	
Consulted with SPE David Payne in regards to the RCE.	1/25/2008	LF	
Consulted with SPE David Payne in regards to the references used to reject the claims.	7/15/2008	LF	
Consulted with SPE David Payne in regards to the patentability of the claims.	11/7/2008	LF	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	354, 371	11/7/2008	LF
455	502, 516	11/7/2008	LF
327	141	11/7/2008	LF

/L. F./
Examiner, Art Unit 2611